

Overview

- · Model fitting
- · Model selection

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Frequentist vs Bayesian

- Probabilistic Model p(y, x, w)
 - Frequentists: w is a parameter that should be estimated by model fitting
 - Bayesians: w is a random variable that has a prior distribution p(w)
 - How to set p(w)??

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Example: Linear regression, what are parameters here? $y{\sim}w_0+\boldsymbol{w}\boldsymbol{x}+e,e{\sim}N(0,\sigma^2)$ $y \sim N(w_0 + \boldsymbol{w}\boldsymbol{x}, \sigma^2)$

- $\hat{\mathbf{w}} = \delta(D)$ (some function of your data) an **estimator**
- Optimal parameter values?→there can be many ways to compute them (MLE, shrinkage...)
 - Compare Bayesian: given estimators w^1 and w^2 , we can compare them! $p(w^1|D) > p(w^2|D)$

An estimator

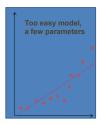
- There is no easy way to compare estimators in frequentist tradition

Example: Linear regression

- Estimator 1: $\mathbf{w} = (X^T X)^{-1} X^T Y$ (maximum likelihood)
- Estimator 2: w = (0, ..., 0, 1)
- Which one is better?
 - A comparison strategy is needed!

Overfitting

• Complex model can overfit your data







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Overfitting: solutions

- Observed: Maximum likelihood can lead to overfitting.
- Solutions
 - Selecting proper parameter values
 - · Regularized risk minimization
 - Selecting proper model type, for ex. number of parameters
 - · Houldout method
 - Cross-validation

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Model selection

- Given a model, choose the optimal parameter values
 Decision theory
- Define loss $L(Y, \hat{y})$
 - How much we loose in guessing true Y incorrectly
- If we know the true distribution p(y, x|w) then we choose \hat{y}

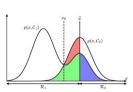
 $\min_{\hat{f}} EL(y,\hat{y}) = \min_{\hat{y}} \int L(y,\hat{y}) p(y,x|w) dx dy$

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Model selection

Example: Spam classification

- · Loss for incorrect classifying mails and spams
 - $\ L_{12} = 100, L_{21} = 1$



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Loss functions

- How to define loss function?
 - No unique choice, often defined by application
 - Normal practice: Choose the loss related to minus loglikelihood

Example: Predicting the amount of the product at the storage:

$$L(Y, \hat{y}) = \begin{cases} 10 + \frac{\hat{y}}{Y}, \hat{y} \ge Y \\ 1000, \hat{y} < Y \end{cases}$$

Example: Compute loss function related to

- Normal distribution

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Guess why such loss function was chosen

Loss functions

- Classification problems
 - Common loss function $L(Y, \hat{y}) = \begin{cases} 0, Y = \hat{y} \\ 1, Y \neq \hat{y} \end{cases}$
 - When minimizing the loss, equivalent to misclassification rate

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Model selection

- Problem: true model and true w are unknown→can not compute expected loss!
- · How to find an optimal model?
 - Consider what expected loss (**risk**) depends on $R(Y, \hat{y}) = E[L(Y, \hat{y}(X, D))]$
- · Random factors:
 - D training set
 - Y, X data to be predicted (validation set)

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Holdout method

- · Simplify the risk estimation:
 - Fix D as a particular training set T
 - Fix Y,X as a particular validation set V
- Risk becomes (empirical risk)

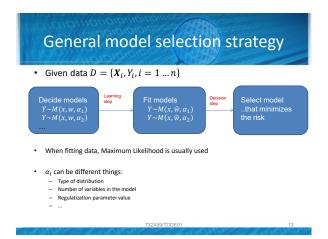
$$\hat{R}(y,\hat{y}) = \frac{1}{|V|} \sum_{(X,Y) \in V} L(Y,\hat{y}(X,T))$$

- Estimator is fit by Maximum Likelihood using training set
- Risk estimated by using validation set
- Model with minimum empirical risk is selected

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Holdout method

Divide into training, validation and test sets



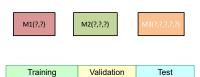
• Choose proportions in some way

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Holdout method

 Given: training, validation, test sets and models to select between



Holdout method

 Training set is to used for fitting models to the dataset by using maximum likelihood



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Holdout method

 Validation set is used to choose the best model (lowest risk)

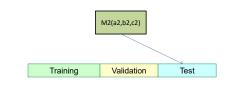
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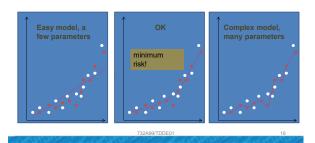
Holdout method

 Test set is used to test a performance on a new data



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Holdout method



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Holdout in R

- How to partition into train/test?
 - Use set.seed(12345) in the labs to get identical results

n=dim(data)[1] set.seed(12345) id=sample(1:n, floor(n*0.7)) train=data[id,] test=data[-id,]

• How to partition into train/valid/test?

nddim(data)[1] set.seed(12345) id=sample(1:n, floor(n*0.4)) traln-data[id,] idl=setdiff(1:n, id) set.seed(12345) id2=sample(id1, floor(n*0.3)) valid-data[id2,] id3=setdiff(id1,id2) test=data[id3,]

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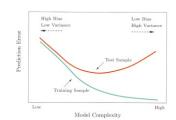
Bias-variance tradeoff

- Bias of an estimator $Bias(\hat{y}(x_0)) = E[\hat{y}(x_0) f(x_0)], f(x_0)$ is expected response
 - If $Bias(\hat{y}(x_0)) = 0$, the estimator is **unbiased**
 - ML estimators are asymptotically unbiased if the model is enough complex
 - However, unbiasedness does not mean a good choice!

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Bias-variance tradeoff

• Assume loss is $L(Y, \hat{y}) = (Y - \hat{y})^2$ $R(Y(x_0), \hat{y}(x_0)) = \sigma^2 + Bias^2(\hat{y}(x_0)) + Var(\hat{y}(x_0))$



When loss is not quadratic, no such nice formula exist

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Cross-validation

· Compared to holdout method:

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— Why do we use only some portion of data for training- can we use more (increase accuracy)?

Cross-validation (Estimates Err)

K-fold cross-validation (rough scheme, show picture):

- 1. Permute the observations randomly
- 2. Divide data-set in K roughly equally-sized subsets
- 3. Remove subset #i and fit the model using remaining data.
- 4. Predict the function values for subset #i using the fitted model.
- 5. Repeat steps 3-4 for different i
- CV= squared difference between observed values and predicted values (another function is possible)

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Cross-validation

Cross-validation



Note: if K=N then method is *leave-one-out* cross-validation.

 $\kappa: \{1, \dots, N\} \mapsto \{1, \dots, K\}$

K-fold cross-validation: $CV = \frac{1}{N} \sum_{i=1}^{N} L(Y_i, \hat{y}^{-k(i)}(x_i))$

What to do if N is not a multiple of K?

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Cross-validation vs Holdout

- Holdout is easy to do (a few model fits to each data)
- Cross validation is computationally demanding (many model fits)
- · Holdout is applicable for large data
 - Otherwise, model selection performs poorly
- · Cross validation is more suitable for smaller data

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Analytical methods

Analytical expressions to select models

 AIC (Akaike's information criterion)

Idea: Instead of $R(Y, \hat{y}) = E[L(Y, \hat{y}(X, D))]$ consider **in-sample** risk (only Y in D is random):

$$R_{in}(Y, \hat{y}) = \frac{1}{N} \sum_{i=1}^{N} E_{Y_i} [L(Y_i, \hat{y}(X, D)) | D, X \in D]$$

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Analytical methods

One can show that

$$R_{in}(Y, \hat{y}) \approx R_{train} + \frac{2}{N} \sum_{i} cov(\hat{y}_i, Y_i)$$

where $R_{train} = \sum_{X_i, Y_i \in T} L(Y_i, \widehat{y_i})$

- Recall, degrees of freedom $df(model) = \frac{1}{\sigma^2} \sum_i cov(\hat{y}_i, Y_i)$
 - When model is linear, *df* is the number of parameters.
- If loss is defined by minus two loglikelihood, $AIC \equiv -2loglik(D) + 2df(model)$

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Model selection

Example Computer Hardware Data Set: performance measured for various processors and also

- · Cycle time
- Memory
- · Channels
- ...

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Build model predicting performance



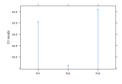
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Cross-validatation

• Try models with different predictor sets

data=read.csv("machine.csv", header=F)
library(cvTools)

fit1-lm(V9-V3-V4+V5-V6+V7+V8, data=data)
fit2-lm(V9-V3-V4+V5-V6+V7, data=data)
fit2-lm(V9-V3-V4-V5-V6-V7, data=data)
fit3-lm(V9-V3-V4-V5-V6, data=data)
fildy="consecutive")
f2-vcrit(fit1, y-wdata5V9, data=data, K-10, foldType="consecutive")
f3-vcrit(fit3, y-wdata5V9, data=data, K-10, foldType="consecutive")
f3-vcrit(fit3, y-wdata5V9, data=data, K-10, foldType="consecutive")
res=vcSelect(f1, f2, f3)
plot(res)



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